

IGBT

FGS15N40L

General Description

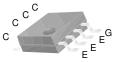
Insulated Gate Bipolar Transistors(IGBTs) with trench gate structure have superior performance in conductance and switching to planar gate structure and also have wide noise immunity. These devices are well suitable for strobe application

Features

- · High Input Impedance
- High Peak Current Capability (130A)
- · Easy Gate Drive

Application

· Strobe Flash







Absolute Maximum Ratings T_C = 25°C unless otherrwise noted

Symbol	Description	FGS15N40L	Units
V _{CES}	Collector-Emitter Voltage	400	V
V _{GES}	Gate-Emitter Voltage	± 6	V
I _{CM (1)}	Pulsed Collector Current	130	А
P _C	Maximum Power Dissipation @	$T_a = 25^{\circ}C$ 2.0	W
T _J	Operating Junction Temperature	-40 to +150	°C
T _{stg}	Storage Temperature Range	-40 to +150	°C
T _L	Maximum Lead Temp. for soldering PurPoses from case for 5 secnds	300	°C

Notes:
(1) Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient(PCB Mount)		62.5	°C/W

Notes: Mounted on 1" square PCB(FR4 or G-10 Material)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Cha	racteristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1mA$	450			V
I _{CES}	Collector Cut-off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			10	μΑ
I _{GES}	G-E leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 0.1	μΑ
On Chai	G-E threshold Voltage	$I_{C} = 0V, I_{C} = 1mA$	-	_	1.4	V
On Chai	acteristics					
V _{CE(sat)}	C-E Saturation Voltage	$I_{C} = 130A$, $V_{GE} = 4.0V$	2.0	4.5	8.0	V
Dynami C _{ies}	C Characteristics Input Capacitance	I		3800		pF
C _{oes}	Output Capacitance	$V_{GE} = 0V$, $V_{CE} = 30V$		45		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz		30		pF
	ng Characteristics					
t _{d(on)}	Turn-On Delay Time	V 200V I 120A		0.15		us
t _r	Rise Time	- V _{CC} = 300V , I _C = 130A - V _{GE} = 4.0V , R _G = 15Ω *		1.5		us
t _{d(off)}	Turn-Off Delay Time	- Resistive Load		0.15	0.3	us
t _f	Fall Time	1 100101110 Load		1.5	3.0	us

Notes : Recommendation of Rg Value : Rg $\geq 15 \Omega$

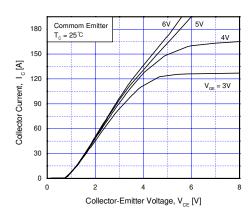


Fig 1. Typical Output Chacracteristics

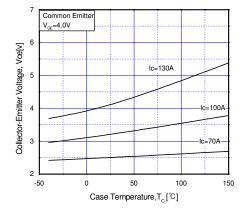


Fig 2. Saturation Voltage vs. Case Temerature at Variant Current Level

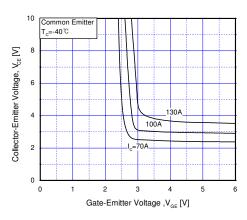


Fig 3. Saturation Voltage vs. V_{GE}

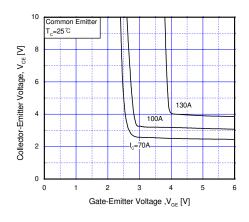


Fig 4. Saturation Voltage vs. V_{GE}

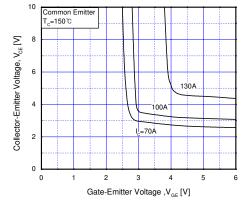


Fig 5. Saturation Voltage vs. V_{GE}

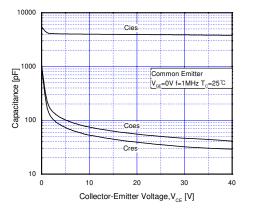


Fig 6. Capacitance Characteristics

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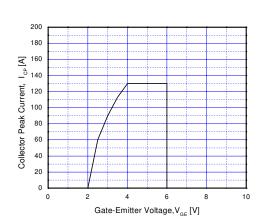
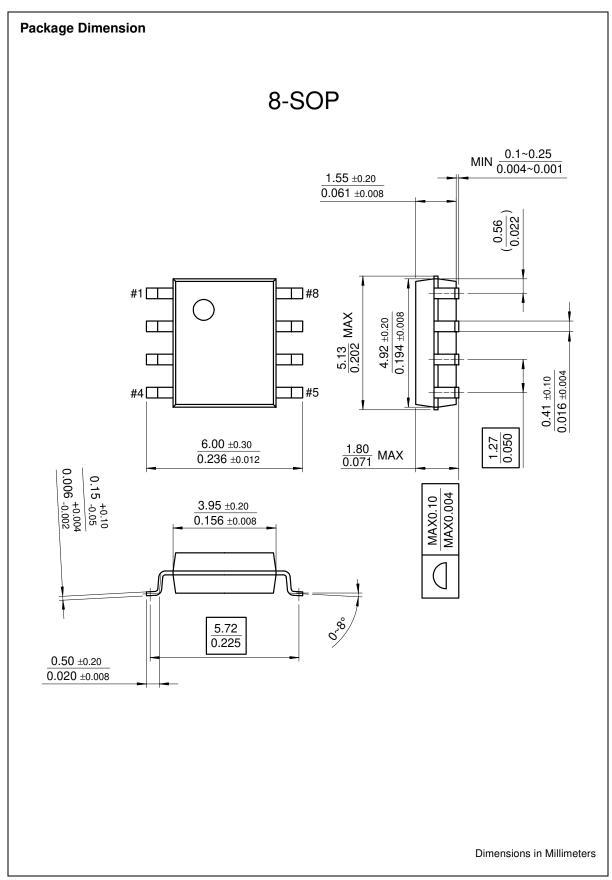


Fig 7. Collector Current Limit Vs Gate - Emitter Voltage Limit

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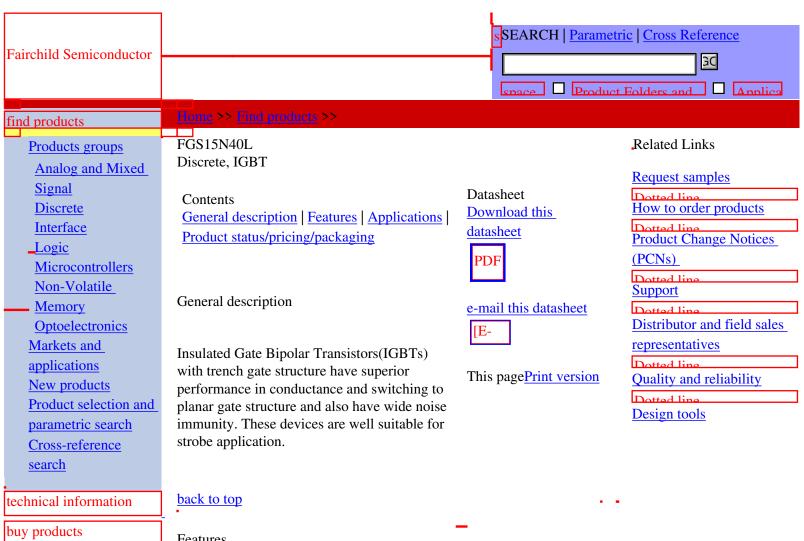
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Features

- High Input Impedance
- High Peak Current Capability (130A)
- Easy Gate Drive

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Applications

Strobe Flash

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FGS15N40LTF	Full Production	\$1.36	SOIC	8	TAPE REEL
FGS15N40LTU	Full Production	\$1.36	SOIC	8	RAIL

^{* 1,000} piece Budgetary Pricing

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